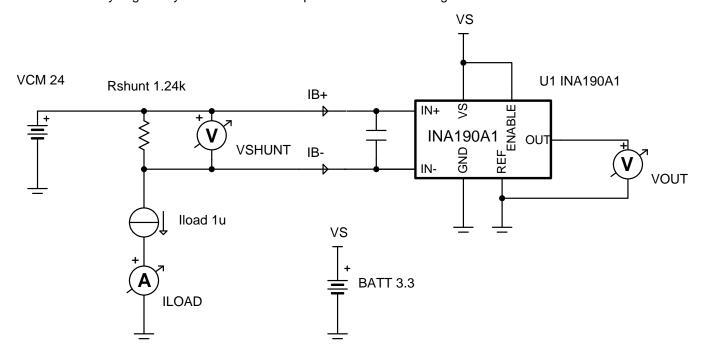


Low (microamp), high-side, current-sensing circuit with current-sensing amplifier at high voltage and overtemperature

Input			Output		Supply			Temperature	
I _{load Min}	I _{load Max}	V _{CM}	V _{OUT Min}	$V_{OUT\ Max}$	I _{Q Max}	V _{VS}	V _{ee}	Low	High
1µA	104µA	-0.1 V \leq V _{CM} \leq 40V	31.0 mV at 1µA	3.224V at 104µA	65µA	3.3V	GND (0V)	0°C	85°C

Design Description

This circuit demonstrates how to use a current sense amplifier to accurately and robustly measure small micro-amp currents and maximize dynamic range. The following error analysis can be applied to many current sense amplifiers. This design relies on using a precision, low input-bias current sense amplifier and analyzing the dynamic error due to input bias currents on large shunt resistors.





Design Notes

- 1. The *Getting Started with Current Sense Amplifiers* video series introduces implementation, error sources, and advanced topic for using current sense amplifiers.
- 2. Choose a precision 0.1% shunt resistor to limit gain error at higher currents.
- 3. Choose a low input-bias current (high input-impedance) amplifier such as the INA190.
- 4. Ensure VCM is within the operating VCM range of INA190: -0.1V to 40V.
- Error significantly reduces if DC offsets are calibrated out with one-point calibration or if device operates under the same conditions as the INA190 Low-Supply, High-Accuracy, Low- and High-Side Current-Shunt Monitor With Picoamp Bias Current and Enable data sheet specifies (V_{VS} = 1.8V, V_{CM} = 12V, V_{REF} = 0.9V, T_A = 25°C). A two-point calibration can be done to eliminate gain error.
- 6. It is recommended to add ≥ 1-nF input differential capacitor to INA190 inputs when working with large shunt resistors and DC currents.
- 7. Follow best practices for layout according to the data sheet: decoupling capacitor close to VS pin, routing the input traces for IN+ and IN- as a differential pair, and so forth.

Design Steps

Given the design requirements, ensure the shunt resistor achieves a maximum total error of 3.51% at 1-μA load current. Assume all offset and gain errors are negative. Note that error due to input bias current (I_{IB}) is a function of the V_{SHUNT} and input differential impedance (R_{DIFF}) where R_{DIFF} = I_{IB+}/V_{DIFF}. Since I_{IB-} starts around +500pA and decreases as V_{SHUNT} increases, this generates a negative input offset error. See the "IB+ and IB- vs Differential Input Voltage" plot in the data sheet.

$$\begin{split} &T_{\text{MIN}} = 0^{\text{O}}\text{C}; T_{\text{MAX}} = 85^{\text{O}}\text{C} \\ &I_{\text{LOAD_MINIMUM}} = 1\mu\text{A} \\ &R_{\text{SHUNT}} = 1240\Omega, 0.1\% \\ &V_{\text{VS}} = 3.3\text{V}; V_{\text{CM}} = 24\text{V}; V_{\text{REF}} = \text{GND} = 0\text{V} \\ &V_{\text{OS}_\text{MAX}} = -15\mu\text{V} \\ &V_{\text{OS}_\text{CMRR_MAX}} = |12\text{V} - \text{V}_{\text{CM}}| \cdot 10 \\ &V_{\text{OS}_\text{PSRR_MAX}} = |1.8\text{V} - \text{V}_{\text{CM}}| \cdot 10 \\ &V_{\text{OS}_\text{PSRR_MAX}} = |1.8\text{V} - \text{V}_{\text{CM}}| \cdot 10 \\ &V_{\text{OS}_\text{PSRR_MAX}} = |1.8\text{V} - \text{V}_{\text{CM}}| \cdot 10 \\ &V_{\text{OS}_\text{PSRR_MAX}} = |0.9\text{V} - \text{V}_{\text{REF}}| \cdot \text{RVRR}_{\text{MAX}} = 3.2\text{V} \cdot 5^{\mu\text{V}}_{\text{V}} = -7.5\mu\text{V} \\ &V_{\text{OS}_\text{Drift}_\text{MAX}} = |0.9\text{V} - \text{V}_{\text{REF}}| \cdot \text{RVRR}_{\text{MAX}} = 0.9\text{V} \cdot 10^{\mu\text{V}}_{\text{V}} = -9\mu\text{V} \\ &V_{\text{OS}_\text{Drift}_\text{MAX}} = |25^{\circ}\text{C} - \text{T}_{\text{MAX}}| \cdot (\frac{\text{dV}_{\text{OS}}}{\text{dT}})_{\text{MAX}} = 60^{\circ}\text{C} \cdot 80^{\text{nV}}_{\text{V}} = -4.8\mu\text{V} \\ &V_{\text{OS}_\text{IB}_\text{MAX}} = \text{func} \left\{ V_{\text{SHUNT}} \right\} = R_{\text{SHUNT}} \cdot \left[\frac{-V_{\text{SHUNT}}}{R_{\text{DIFF}}} + I_{\text{IB}_\text{Typ}} \right] = 1240\Omega \cdot \left[\frac{-1.24\text{mV}}{2.3\text{M}\Omega} + 0.5\text{nA} \right] = -48.5\text{nV} \\ &V_{\text{OS}_\text{MAX}} = \sqrt{\text{OS}_\text{IMAX}} + V_{\text{OS}_\text{CMRR}} + V_{\text{OS}_\text{PSRR}} + V_{\text{OS}_\text{RVRR}} + V_{\text{OS}_\text{Drift}_\text{Max}} + V_{\text{OS}_\text{IB}_\text{MAX}} \\ &V_{\text{OS}_\text{MAX}} = -39.4\mu\text{V} \\ &R_{\text{shunt_tolerance}} = -0.1\% = 0.001 \\ &GE_{25\text{C}_\text{MAX}} = -0.3\% = -0.003 \\ &GE_{\text{Drift}_\text{MAX}} = -7^{\text{ppm}} / \text{C} \cdot (85^{\circ}\text{C} - 25^{\circ}\text{C}) \cdot 10^{-6} = -0.00042 \\ &Gain_{\text{MAX}} = 25 \cdot (1 + \text{GE}_{25\text{C}_\text{MAX}} + \text{GE}_{\text{Drift}_\text{MAX}}) = 25 \cdot (0.99758) = 24.940 \text{V/} \\ &V_{\text{OUT}_\text{IMN}} - \mu_{\text{A}} = [V_{\text{OS}_\text{MAX}} + I_{\text{LOAD}} \cdot R_{\text{SHUNT}} \cdot (1 + R_{\text{shunt}_\text{tolerance}})] \cdot \text{Gain}_{\text{MAX}} = 29.9\text{mV} \\ &V_{\text{OUT}_\text{IDEAL}_1\mu\text{A}} = [I_{\text{LOAD}_\text{MINIMUM}} \cdot R_{\text{SHUNT}} \cdot (1 + R_{\text{shunt}_\text{tolerance}})] \cdot \text{Gain}_{\text{MAX}} = 29.9\text{mV} \\ &V_{\text{OUT}_\text{IDEAL}} - 1\mu_{\text{A}} = [I_{\text{LOAD}_\text{MINIMUM}} \cdot R_{\text{SHUNT}}] \cdot \text{Gain} = 31.0\text{mV} \\ &\text{Error}_{\text{BuA}} = -0.91\% \\ &\text{Error}_{\text{BuA}} = -0.91\% \end{aligned}$$



- 2. Ensure the sensed current range fits within the output dynamic range of the device. This depends upon two specifications: Swing-to- V_{VS} (V_{SP}) and Zero-current Output Voltage (V_{ZL}). V_{ZL} is specified over -40°C to +125°C at V_{VS} = 1.8V, V_{REF} = 0V, V_{SENSE} = 0mV, V_{CM} = 12V, and R_L = 10k Ω . Since data sheet conditions do not match the conditions of this design, extrapolate what the maximum V_{ZL} would be.
 - a. Calculate the maximum possible positive offset for testing conditions of V_{ZL} . Call this $V_{OS\ TestConditions}$.
 - b. Convert this input offset into an output offset by multiplying by maximum possible gain.
 - c. Determine the Headroom voltage by taking difference between the V_{ZL_MAX} from data sheet and the previously determined maximum output offset.
 - d. Calculate V_{ZL_MAX} in this design by adding the Headroom voltage to the maximum possible output offset for this design.
 - e. Ensure that the minimum V_{OUT} at $1\mu A$ is greater than V_{ZL_MAX} . Note V_{OUT_MIN} at $1\mu A$ assumes worst-case scenario of -1% tolerance for R_{SHUNT} and negative input offsets.

$$\begin{split} &V_{OS_TestConditions} = V_{OSI_MAX} + |\: 0.9V - 0V\:| \cdot RVRR_{MAX} + |\: 125^{\circ}C + 40^{\circ}C\:| \cdot (\frac{dV_{OS}}{dT})_{MAX} \\ &V_{OS_TestConditions} = +15\mu V + 9\mu V + 13.2\mu V = 37.2\mu V \\ &Headroom = V_{ZL_MAX_DATASHEET} - V_{OS_TestConditions} \cdot Gain_{MAX} \\ &Headroom = 3mV - 0.933mV = 2.07mV \end{split}$$

$$\begin{split} &V_{ZL_MAX} = Headroom + V_{OS_MAX} \cdot Gain_{MAX} = 2.07 mV + (39.4 \mu V \cdot 25.061 \frac{V}{V}) = 3.06 mV \\ &V_{OUT_MIN_1\mu A} = 29.9 \, mV > V_{ZL_MAX} \end{split}$$

f. Now ensure the maximum V_{OUT} at 104 μ A is less than V_{SP_MIN} . Note V_{OUT_MAX} at 104 μ A assumes worst-case scenario of +1% tolerance for R_{SHUNT} and positive input offsets.

$$\begin{split} &V_{SP_MIN} = V_{VS} - 40mV = 3.26V \\ &V_{OUT_MAX} = \left[R_{SHUNT} \cdot (1 + R_{shunt_tolerance}) \cdot I_{LOAD_MAX} + V_{OS_MAX}\right] \cdot Gain_{MAX} \\ &V_{OUT_MAX} = \left[1240\Omega \cdot (1.001) \cdot 104\mu A - 29.6\mu V\right] \cdot 25.061 \text{ V/}_{V} = 3.234V \\ &V_{OUT_MAX} < V_{SP_MIN} \end{split}$$

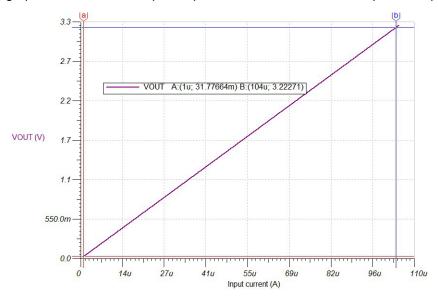
Generate Total Error vs Load Current curves based upon the total error equations in Step 1. Do this for the typical and maximum data sheet specifications.



Design Simulations

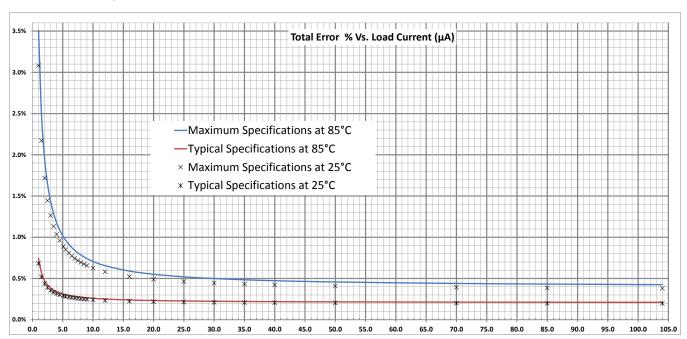
DC Simulation Results

The following graph shows a linear output response for load currents from 1µA to 104µA



Total Error Calculations

The following graph shows the total absolute error over temperature using both the assured limit specifications and the typical specifications. Note that accuracy is limited by the offset voltage at the lowest current sensed and limited by gain error at higher currents. Active offset chopping limits the error due to temperature.



www.ti.com

Design References

See Analog Engineer's Circuit Cookbooks for TI's comprehensive circuit library.

See circuit SPICE simulation file SBOMAI6.

Getting Started with Current Sense Amplifiers video series

https://training.ti.com/getting-started-current-sense-amplifiers

Application Note on Power-Saving Topologies for TI Current Shunt Monitors

http://www.ti.com/lit/an/sboa180a/sboa180a.pdf

Current Sense Amplifiers on Tl.com

http://www.ti.com/amplifier-circuit/current-sense/products.html

For direct support from TI Engineers use the E2E community

http://e2e.ti.com

Design Featured Current Shunt Monitor

INA190A1						
V _{vs}	1.8V to 5V (operating)					
V _{CM}	-0.3V to 42V (survivability)					
V _{out}	Up to $(V_{VS}) + 0.3V$					
V _{os}	±3μV to ±15μV					
I _Q	48μA to 65μA					
I _{IB}	0.5nA to 3nA					
BW	45kHz at 25V/V (A1 gain variant)					
# of Channels	1					
http://www.ti.com/product/ina190						

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